Notice of References Cited

Application/Control No.

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Examiner

April L Baugh

Applicant(s)/Patent Under
Reexamination
CRANDALL, EVAN STEPHEN

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5,455,626	10-1995	Xu et al.	348/385.1
	В	US-5,701,582	12-1997	DeBey, Henry C.	725/103
	С	US-6,151,078	11-2000	Yoneda et al.	348/558
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	Н	US-			
	1	US-			
	J	US-			·
	к	US-	_		
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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NON-PATENT DOCUMENTS

NON-PATENT DOCUMENTS							
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
	U						
	V						
	w						
	x						

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